Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/015,848	PAYNE ET AL.	
Examiner	Art Unit	

2611

Jason M. Perilla

	SEAR	CHED	
Class	Subclass	Date	Examiner
375	346	8/25/2005	JP
	350	8/25/2005	JP

INT	ERFERENC	E SEARCH	ED
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East EPO/JPO USPAT/USPGPUB	5/25/06	JP	
Inventor Name Search East/EDAN	8/25/2005	JP	
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